#### TOSHIBA PHOTOCOUPLER GaAs IRED & PHOTO-TRANSISTOR

# **TLP291(SE**

# Power Supplies Programmable Controllers Hybrid ICs

TLP291(SE consists of photo transistor optically coupled to a gallium arsenide infrared emitting diode.

TLP291(SE is housed in the SO4 package, very small and thin coupler. Since TLP291(SE is guaranteed wide operating temperature (Ta=-55 to 110 °C) and high isolation voltage (3750Vrms), it's suitable for high-density surface mounting applications such as small switching power supplies and programmable controllers.

Collector-Emitter Voltage : 80 V (min)
 Current Transfer Ratio : 50% (min)
 Rank GB : 100% (min)
 Isolation Voltage : 3750 Vrms (min)

Operation temperature: -55 to 110 °C

UL recognized : UL1577, File No. E67349

• cUL approved : CSA Component Acceptance Service No.5A,

File No. E67349

SEMKO conformity : EN 60065: 2002,

EN 60950-1: 2001, EN 60335-1: 2002,

BSI conformity: BS EN 60065: 2002,

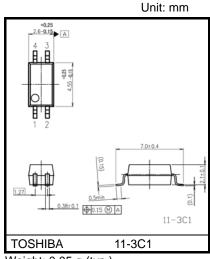
BS EN 60950-1: 2006

VDE conformity: EN 60747-5-5

Construction Mechanical Rating
Creepage distance: 5.0mm(min)

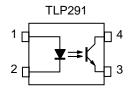
Clearance: 5.0mm(min)

Insulation thickness: 0.4mm(min)



Weight: 0.05 g (typ.)

## **Pin Configuration**



1:ANODE 2:CATHODE 3:EMITTER 4:COLLECTOR

# Current Transfer Ratio (CTR) Rank (Unless otherwise specified, Ta = 25°C)

TYPE	Classification (Note1)	Current Trans (I <sub>C</sub>	sfer Ratio (%) / I <sub>F</sub> )	Madian of Olassification	
		$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}, Ta = 25^{\circ}\text{C}$		Marking of Classification	
		Min	Max		
	Blank	50	600	Blank, YE, GR, GB, BL, Y+, G, G+,B	
	Rank Y	50	150	YE	
	Rank GR	100	300	GR	
	Rank GB	100	600	GB	
TLP291	Rank BL	200	600	BL	
	Rank YH	75	150	Y+	
	Rank GRL	100	200	G	
	Rank GRH	150	300	G+	
	Rank BLL	200	400	В	

Note1: Specify both the part number and a rank in this format when ordering

(e.g.) rank GB: TLP291 (GB,SE

For safety standard certification, however, specify the part number alone.

(e.g.)TLP291 (GB,SE: TLP291

### Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25°C)

CHARACTERISTIC		SYMBOL	NOTE	RATING	UNIT
Input forward current		I <sub>F</sub>		50	mA
Input forward current derating (Ta≥90°C)		ΔI <sub>F</sub> /ΔTa		-1.5	mA /°C
	Input forward current (pulsed )	I <sub>FP</sub>	(Note 2)	1	Α
LED	Input reverse voltage	V <sub>R</sub>		5	V
	Input power dissipation	P <sub>D</sub>		100	mW
	Input power dissipation derating (Ta ≥ 90°C)	ΔP <sub>D</sub> /ΔTa		-3.0	mW/°C
	Junction temperature	Тj		125	°C
	Collector-emitter voltage	V <sub>CEO</sub>		80	V
~	Emitter-collector voltage	V <sub>ECO</sub>		7	V
Collec Collec	Collector current	Ic		50	mA
ETE(	Collector power dissipation	PC		150	mW
□	Collector power dissipation derating(Ta≥25°C)	ΔP <sub>C</sub> / <b>Δ</b> Ta		-1.5	mW /°C
	Junction temperature	Тj		125	°C
Operating temperature range		T <sub>opr</sub>		-55 to 110	°C
Storage temperature range		T <sub>stg</sub>		-55 to 125	°C
Lead soldering temperature		T <sub>sol</sub>		260 (10s)	°C
Total package power dissipation		P <sub>T</sub>		200	mW
Tota	al package power dissipation derating(Ta≥25°C)	ΔΡ⊤ /ΔΤα		-2.0	mW /°C
Isolation voltage		BVS	(Note3)	3750	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note2: Pulse width  $\leq 100 \mu s$ , frequency 100Hz

Note3: AC, 1 minute, R.H.≤60%, Device considered a two terminal device: LED side pins shorted together and DETECTOR side pins shorted together.

#### Electrical Characteristics (Unless otherwise specified, Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
	Input forward voltage	V <sub>F</sub>	I <sub>F</sub> = 10 mA	1.1	1.25	1.4	V
E	Input reverse current	I <sub>R</sub>	V <sub>R</sub> = 5 V	-	-	5	μΑ
$\lfloor \cdot \rfloor$	Input capacitance	pacitance $C_T$ $V = 0 V, f = 1 MHz$		-	30	-	pF
	Collector-emitter breakdown voltage	V <sub>(BR)</sub> CEO	I <sub>C</sub> = 0.5 mA	80	-	-	V
OR.	Emitter-collector breakdown voltage	V <sub>(BR)</sub> ECO	I <sub>E</sub> = 0.1 mA	7	-	1	V
DETECTOR	Dark current	I <sub>DARK</sub>	V <sub>CE</sub> = 48 V	1	0.01	0.08	μΑ
			V <sub>CE</sub> = 48 V, Ta = 85°C	1	2	50	μΑ
	Collector-emitter capacitance	C <sub>CE</sub>	V = 0 V, f = 1 MHz	-	10	-	pF

# Coupled Electrical Characteristics (Unless otherwise specified, Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Current transfer ratio	I <sub>C</sub> / I <sub>F</sub>	I <sub>F</sub> = 5 mA, V <sub>CE</sub> = 5 V	50	-	600	- %
Current transfer fatto		Rank GB	100	-	600	
Saturated current transfer ratio	I <sub>C</sub> / I <sub>F (sat)</sub>	$I_F = 1 \text{ mA}, V_{CE} = 0.4 \text{ V}$	-	60	1	%
		Rank GB	30	-	-	/0
	V <sub>CE</sub> (sat)	I <sub>C</sub> = 2.4 mA, I <sub>F</sub> = 8 mA	-	-	0.3	V
Collector-emitter saturation voltage		I <sub>C</sub> = 0.2 mA, I <sub>F</sub> = 1 mA	-	0.2	-	
		Rank GB	-	-	0.3	
OFF-state collector current	I <sub>C (off)</sub>	V <sub>F</sub> = 0.7 V, V <sub>CE</sub> = 48 V	-	-	10	μА

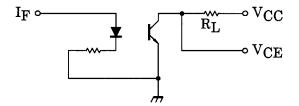
# Isolation Characteristics (Unless otherwise specified, Ta = 25°C)

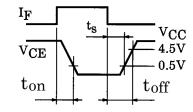
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Total capacitance (input to output)	Cs	V <sub>S</sub> = 0 V, f = 1 MHz	-	8.0	-	pF
Isolation resistance	R <sub>S</sub>	V <sub>S</sub> = 500 V, R.H.≤60%	1×10 <sup>12</sup>	10 <sup>14</sup>	-	Ω
		AC , 1 minute	3750	=	-	Vrms
Isolation voltage	BVS	AC , 1 second, in OIL	-	10000	-	VIIIIS
		DC , 1 minute, in OIL	-	10000	-	Vdc

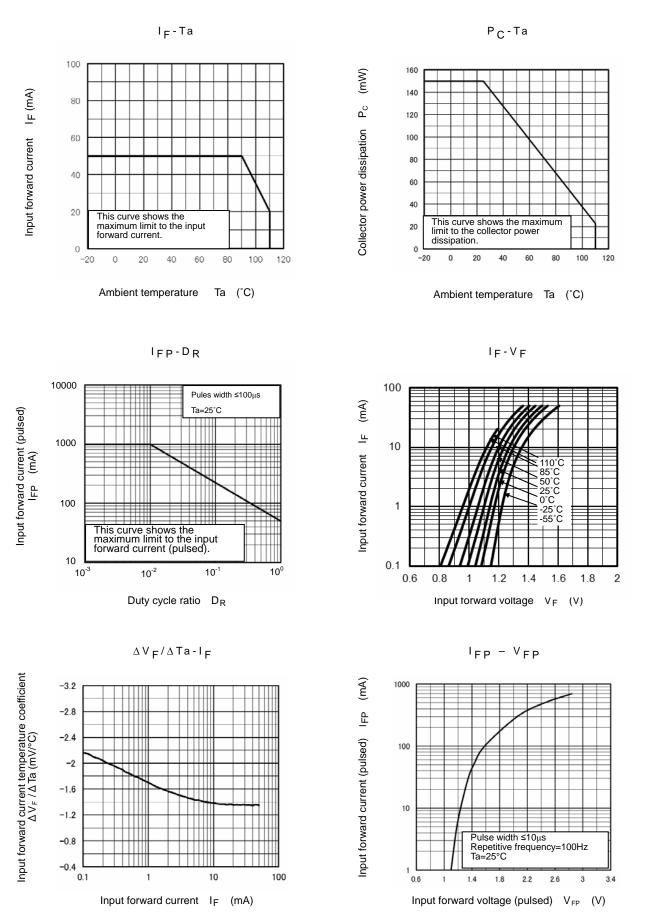
# **Switching Characteristics (Unless otherwise specified, Ta = 25°C)**

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Rise time	t <sub>r</sub>	$V_{CC} = 10 \text{ V, } I_{C} = 2 \text{ mA}$ $R_{L} = 100\Omega$	-	2	-	μs
Fall time	t <sub>f</sub>		-	3	-	
Turn-on time	t <sub>on</sub>		1	3	-	
Turn-off time	t <sub>off</sub>		-	3	-	
Turn-on time	t <sub>on</sub>		1	0.5	-	
Storage time	ts	$R_L = 1.9 \text{ k}\Omega$ (Fig.1 $V_{CC} = 5 \text{ V}, I_F = 16 \text{ mA}$	-	25	-	μS
Turn-off time	t <sub>off</sub>		=	40	-	

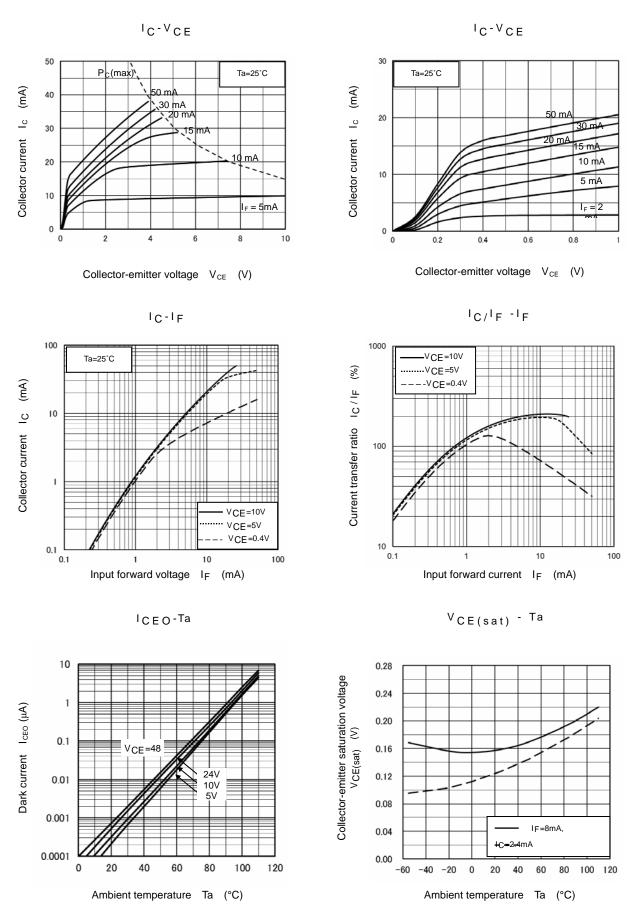
(Fig.1) Switching Time Test Circuit





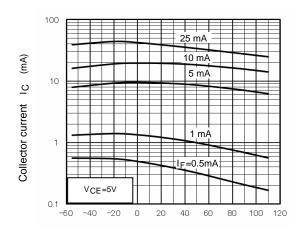


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted



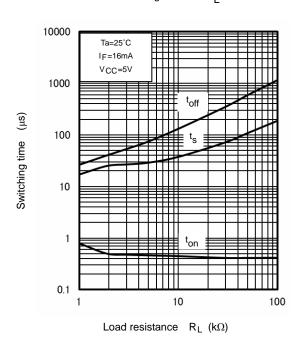
Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted

I<sub>C</sub> - Ta

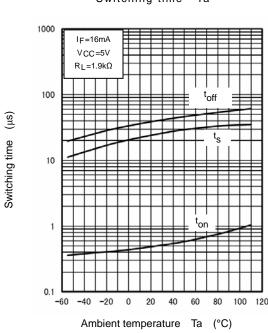


Ambient temperature Ta (°C)

Switching time -  $R_L$ 



Switching time - Ta



Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

# **Soldering and Storage**

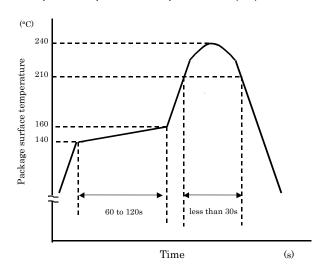
#### 1. Soldering

#### 1.1 Soldering

When using a soldering iron or medium infrared ray/hot air reflow, avoid a rise in device temperature as much as possible by observing the following conditions.

#### 1) Using solder reflow

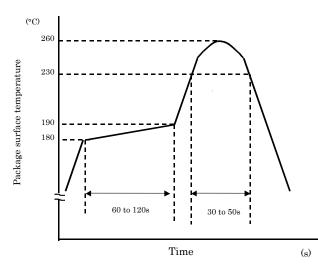
·Temperature profile example of lead (Pb) solder



This profile is based on the device's maximum heat resistance guaranteed value.

Set the preheat temperature/heating temperature to the optimum temperature corresponding to the solder paste type used by the customer within the described profile.

·Temperature profile example of using lead (Pb)-free solder



This profile is based on the device's maximum heat resistance guaranteed value.

Set the preheat temperature/heating temperature to the optimum temperature corresponding to the solder paste type used by the customer within the described profile.

Reflow soldering must be performed once or twice.

The mounting should be completed with the interval from the first to the last mountings being 2 weeks.

- 2) Using solder flow (for lead (Pb) solder, or lead (Pb)-free solder)
  - Please preheat it at 150°C between 60 and 120 seconds.
  - · Complete soldering within 10 seconds below 260°C. Each pin may be heated at most once.
- 3) Using a soldering iron

Complete soldering within 10 seconds below 260°C, or within 3 seconds at 350°C. Each pin may be heated at most once.

#### 2. Storage

- 1) Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- 2) Follow the precautions printed on the packing label of the device for transportation and storage.
- 3) Keep the storage location temperature and humidity within a range of 5°C to 35°C and 45% to 75%, respectively.
- 4) Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- 5) Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation or corrosion, which will deteriorate the solderability of the leads.
- 6) When restoring devices after removal from their packing, use anti-static containers.
- 7) Do not allow loads to be applied directly to devices while they are in storage.
- 8) If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.

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